

<b>Notice of References Cited</b>	Application/Control No. 10/762,361	Applicant(s)/Patent Under Reexamination YOSHIDA ET AL.	
	Examiner Walter L. Lindsay, Jr.	Art Unit 2812	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,165,880	12-2000	Yaung et al.	438/592
	B	US-6,392,310	05-2002	Matsunaga, Daisuke	257/296
	C	US-5,817,562	10-1998	Chang et al.	438/305
	D	US-6,770,417	08-2004	Nozaki et al.	430/270.1
	E	US-6,329,248	12-2001	Yang, Yu-Hao	438/267
	F	US-6,093,945	07-2000	Yang, Yu-Hao	257/317
	G	US-6,770,550	08-2004	Kunikiyo, Tatsuya	438/585
	H	US-6,254,676	07-2001	Yang et al.	438/286
	I	US-5,314,834	05-1994	Mazure et al.	438/301
	J	US-4,480,375	11-1984	Cottrell et al.	438/232
	K	US-6,080,682	06-2000	Ibok, Effiong E.	438/770
	L	US-6,777,761	08-2004	Clevenger et al.	257/388
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.